

SERIAL NO.	GROUP ART UNIT	ATTACHMENT TO PAPER NUMBER
08/169,127	1112	9

NOTICE OF REFERENCES CITED

APPLICANT(S)

Shinohera et al

U.S. PATENT DOCUMENTS

*	DOCUMENT NO.	DATE	NAME	CLASS	SUB-CLASS	FILING DATE IF APPROPRIATE
A	4 444 801	4/84	Hongo et al	427	555	
B	4 473 433	9/84	Bosch et al		555	
C	4 727 234	2/88	Oprysko et al		555	
D	4 784 963	11/88	Krimmel et al		585	
E	4 915 981	4/90	Traskos et al		553	
F	5 084 300	1/29/92	Zander et al		584	
G	5 112 645	5/12/92	Sekine et al	427	583	
H						
I						
J						
K						

FOREIGN PATENT DOCUMENTS

*	DOCUMENT NO.	DATE	COUNTRY	NAME	CLASS	SUB-CLASS	PERTINENT SHTS. DWG.	PP. SPEC.
L	20 9 13 1	1/87	EPO	(NEC Corp) Morishige	427	582	X	X
M	340 708 9	8/85	DE	Krimmel et al	427	582	X	abst
N	3 925 085	1/91	DE	Stafast et al		584	X	abst
O	60-21054 9	10/85	Japan	Misao Suga		583	X	"
P	61-21044 9	9/86	"	NEC Corp		582	X	"
Q	61-27623 3	12/86	"	NEC Corp	427	582	X	"

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

R	01-136,973	5/89	Japan	NEC Corp.	427/583	X	abst
	02-050,963	2/90	Japan	NEC Corp	427/555	X	"
S	02-067,721	3/90	Japan	Hiroyuki IWANU	427/583	X	"
	02-174,123	7/90	Japan	NEC Corp	427/-	X	"
T	03-024,259	2/91	Japan	Toshiba KK	427/-	X	"
U							

EXAMINER

DATE

Theranne L. Spangler 9/15/94

* A copy of this reference is not being furnished with this office action.
(See Manual of Patent Examining Procedure, section 707.05 (a).)